DATA SHEET



MOS FIELD EFFECT TRANSISTOR μ PA1872

N-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

The μ PA1872 is a switching device which can be driven directly by a 2.5 V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

FEATURES

- 2.5 V drive available
- Low on-state resistance

 $R_{DS(on)1} = 13.0 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 4.5 \text{ V, Ip} = 5.0 \text{ A)}$

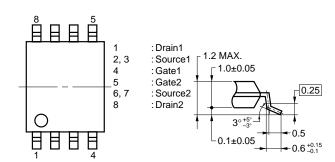
 $R_{DS(on)2} = 13.5 \text{ m}\Omega$ MAX. (Vgs = 4.0 V, ID = 5.0 A)

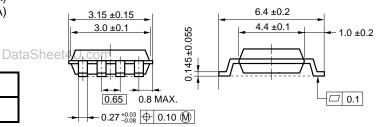
RDS(on)3 = 15.5 m Ω MAX. (Vgs = 3.1 V, ID = 5.0 A)

 $R_{DS(on)4} = 18.0 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 2.5 \text{ V, ID} = 5.0 \text{ A)}$

· Built-in G-S protection diode against ESD

PACKAGE DRAWING (Unit: mm)





ORDERING INFORMATION

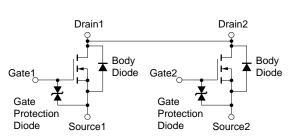
PART NUMBER	PACKAGE
μPA1872GR-9JG	Power TSSOP8

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	20	V
Gate to Source Voltage (Vps = 0 V)	Vgss	±12	V
Drain Current (DC) (T _A = 25°C)	I _{D(DC)}	±10	Α
Drain Current (pulse) Note1	ID(pulse)	±80	Α
Total Power Dissipation (2 unit) Note2	PT	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C

EQUIVALENT CIRCUIT

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Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Mounted on ceramic substrate of 5000 mm² x 1.1 mm

Remark

The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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G15622EJ1V0DS00 (1st edition) December 2001 NS CP(K)

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ELECTRICAL CHARACTERISTICS (TA = 25°C)

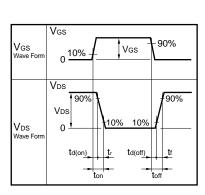
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	Inss	Vps = 20 V, Vgs = 0 V			10	μΑ
Gate Leakage Current	lgss	Vgs = ±12 V, Vps = 0 V			±10	μΑ
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1.0 mA	0.5	1.0	1.5	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 5.0 A	5.0			S
Drain to Source On-state Resistance	RDS(on)1	Vgs = 4.5 V, ID = 5.0 A	8.0	10.0	13.0	mΩ
	RDS(on)2	Vgs = 4.0 V, ID = 5.0 A	8.5	10.5	13.5	mΩ
	RDS(on)3	Vgs = 3.1 V, ID = 5.0 A	9.0	11.5	15.5	mΩ
	RDS(on)4	V _{GS} = 2.5 V, I _D = 5.0 A	10.0	13.5	18.0	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V		1200		pF
Output Capacitance	Coss	V _G S = 0 V		370		pF
Reverse Transfer Capacitance	Crss	f = 1.0 MHz		270		pF
Turn-on Delay Time	td(on)	V _{DD} = 10 V, I _D = 5.0 A		60		ns
Rise Time	tr	V _G S = 4.0 V		350		ns
Turn-off Delay Time	t d(off)	$R_G = 10 \Omega$		450		ns
Fall Time	t _f			640		ns
Total Gate Charge	Q _G	V _{DD} = 16 V		15		nC
Gate to Source Charge	Qgs	Vgs = 4.0 V		2.0		nC
Gate to Drain Charge	Q _{GD}	I _D = 10 A		8.0		nC
Body Diode Forward Voltage	V _F (S-D)	IF = 10 A, Ves = 0 V		0.83		V
Reverse Recovery Time	trr	IF = 10 A, VGS = 0 V		470		ns
Reverse Recovery Charge	Qrr	di/dt = 50 A / μs		990		nC

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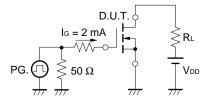
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TEST CIRCUIT 1 SWITCHING TIME

PG. \bigcap $T = 1 \mu s$ Duty Cycle $\leq 1\%$

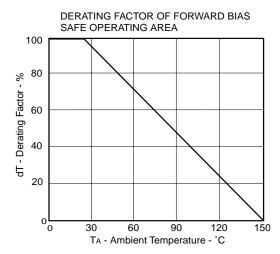


TEST CIRCUIT 2 GATE CHARGE

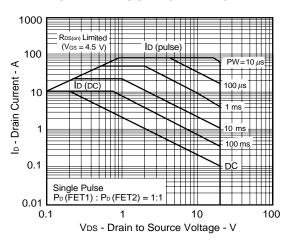


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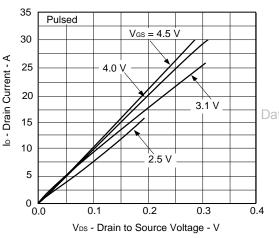
TYPICAL CHARACTERISTICS (TA = 25°C)



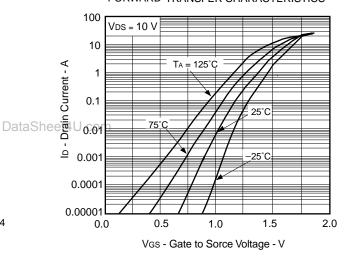
FORWARD BIAS SAFE OPERATING AREA



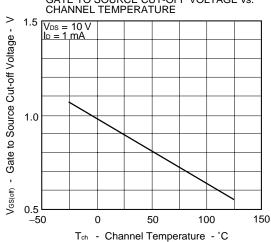
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



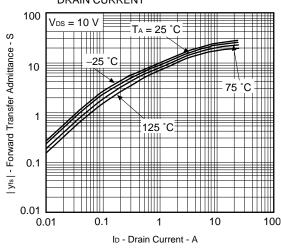
FORWARD TRANSFER CHARACTERISTICS



GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



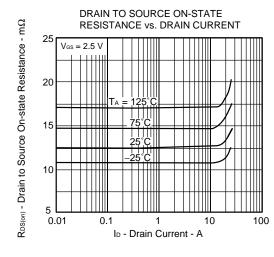
FORWARD TRANSFER ADMITTANCE vs. **DRAIN CURRENT**

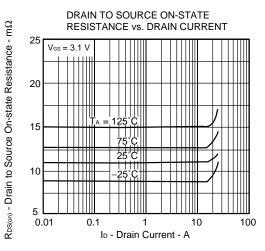


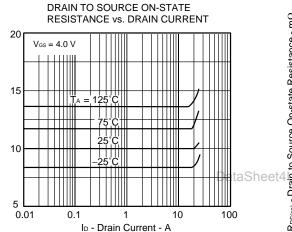
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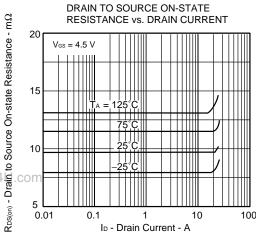
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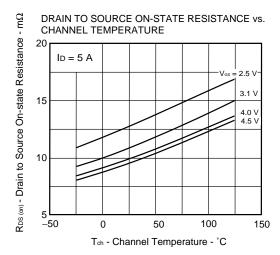
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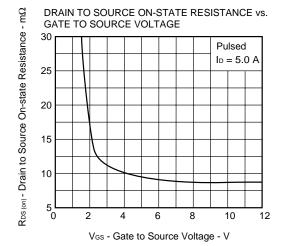








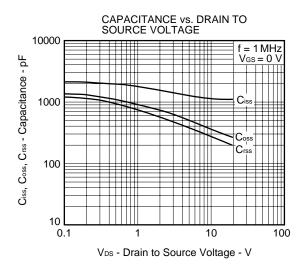


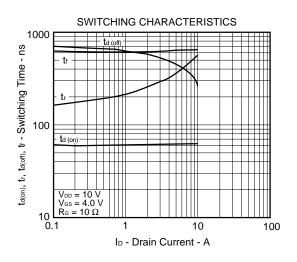


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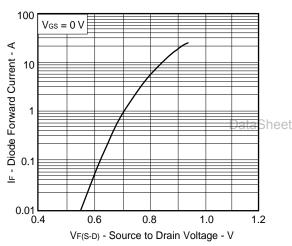
RDS(on) - Drain to Source On-state Resistance - mΩ

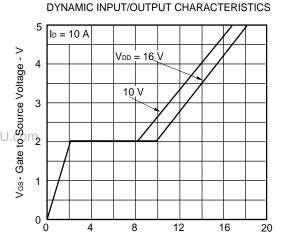
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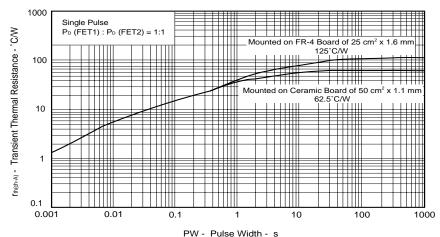
SOURCE TO DRAIN DIODE FORWARD VOLTAGE





Q_G - Gate Charge - nC

TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



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